## Computational Microelectronics Lecture 13 Poisson Equation

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## Source-Free Poisson Equation

## Laplace versus Poisson

Laplace equation

$$\nabla^2 \phi = \nabla \cdot (\nabla \phi) = 0$$

Poisson equation

$$\nabla \cdot [\boldsymbol{\epsilon}(\mathbf{r}) \nabla \phi] = -\rho(\mathbf{r})$$

– When the permittivity is a constant,

$$\nabla \cdot (\nabla \phi) = -\frac{\rho(\mathbf{r})}{\epsilon}$$

- When there is no net charge,

$$\nabla \cdot (\nabla \phi) = 0$$

## Discretization of $\nabla \cdot [\epsilon(\mathbf{r})\nabla \phi]$

• 1D

$$\frac{d}{dx} \left[ \epsilon(x) \frac{d\phi}{dx} \right]$$

-Integration from  $x_{i-0.5}$  to  $x_{i+0.5}$ 

$$\int_{x_{i-0.5}}^{x_{i+0.5}} \frac{d}{dx} \left[ \epsilon(x) \frac{d\phi}{dx} \right] dx = \epsilon(x_{i+0.5}) \frac{d\phi}{dx} \bigg|_{x_{i+0.5}} - \epsilon(x_{i-0.5}) \frac{d\phi}{dx} \bigg|_{x_{i-0.5}}$$

## In 2D or 3D,

- Laplace equation
  - Discretized Laplace equation reads

$$\sum_{j} \frac{\phi_{j} - \phi_{i}}{|\mathbf{r}_{j} - \mathbf{r}_{i}|} A_{ij} = 0$$

- Poisson equation
  - Discretized Poisson equation reads

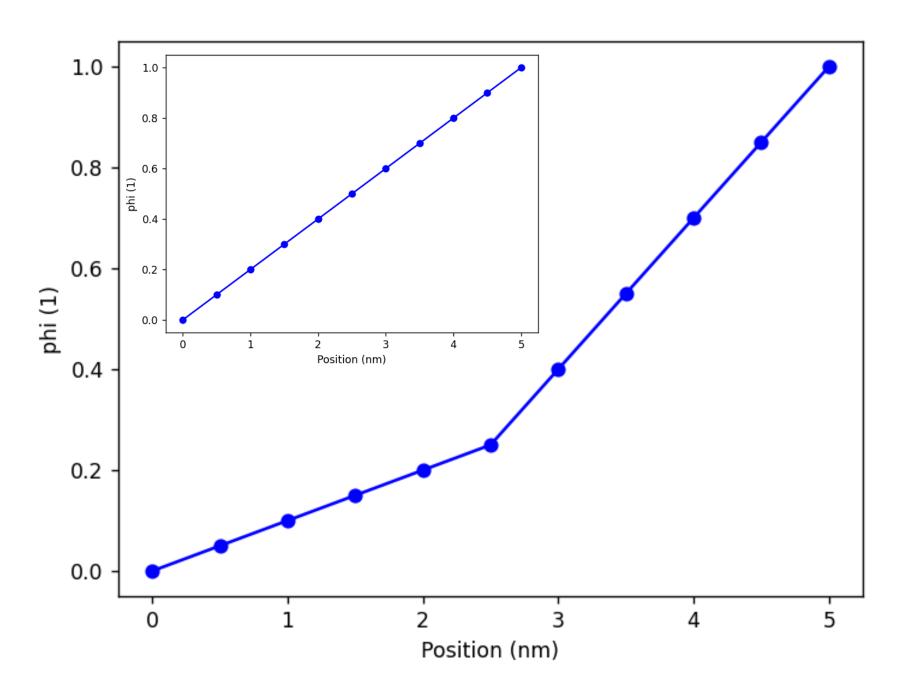
$$\sum_{i} \frac{\phi_{ij}}{|\mathbf{r}_{j} - \mathbf{r}_{i}|} A_{ij} + \rho(\mathbf{r}_{i}) \Omega_{i} = 0$$

## 1D example

- Source-free Poisson equation
  - Consider a capacitor with two layers.
  - Each layer is 2.5-nm-thick.
  - -The first layer (from 0 to 2.5 nm) has a relative permittivity of 11.7.
  - -The second layer (from 2.5 nm to 5 nm) has a relative permittivity of 3.9.
  - -1 V is applied across the capacitor. Calculate the potential,  $\phi$ .

## Its solution

ullet Potential,  $\phi$ 



#### **HW#12**

- Due: AM08:00, October 18
- Problem#1
  - Draw the potential, when the capacitor has the following conditions:
  - -The first layer (from 0 to 2.5 nm) has a relative permittivity of 3.9.
  - -The second layer (from 2.5 nm to 5 nm) has a relative permittivity of 7.4.
  - From the numerical results, calculate its areal capacticance.

# Poisson Equation with Fixed Charges

## Poisson equation with fixed chrages

Charges inside semiconductor

$$\rho(\mathbf{r}) = qp(\mathbf{r}) - qn(\mathbf{r}) + qN_{dop}^{+}(\mathbf{r})$$

- Hole density,  $p(\mathbf{r})$
- Electron density,  $n(\mathbf{r})$
- Doping density,  $N_{dop}^+(\mathbf{r})$
- Calculating  $p(\mathbf{r})$  and  $n(\mathbf{r})$  is the main goal of TCAD simulation!
  - It's not an easy task.
  - Without  $p(\mathbf{r})$  and  $n(\mathbf{r})$ ,

$$\nabla \cdot [\epsilon(\mathbf{r})\nabla \phi] = -qN_{dop}^{+}(\mathbf{r})$$

#### Discretization

Integrated form in 1D

$$\begin{aligned}
& \left. \epsilon(x_{i+0.5}) \frac{d\phi}{dx} \right|_{x_{i+0.5}} - \epsilon(x_{i-0.5}) \frac{d\phi}{dx} \right|_{x_{i-0.5}} \\
&= -q N_{dop}^{+}(x_i) (x_{i+0.5} - x_{i-0.5})
\end{aligned}$$

Explicitly,

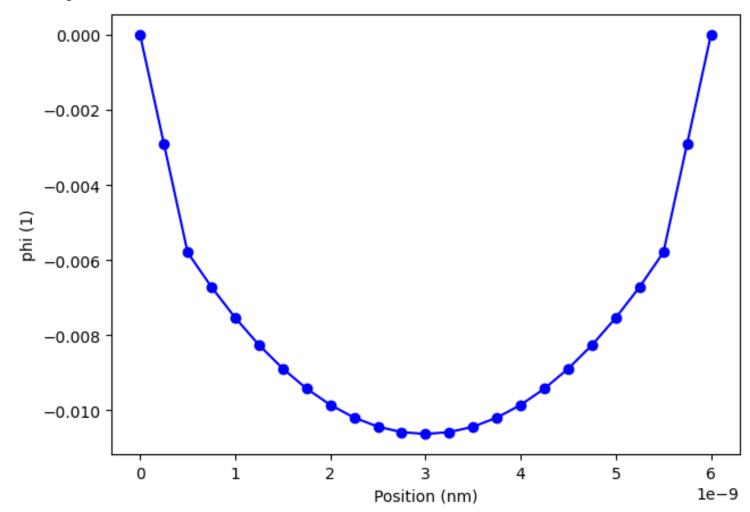
$$\epsilon(x_{i+0.5}) \frac{\phi(x_{i+1}) - \phi(x_i)}{x_{i+1} - x_i} - \epsilon(x_{i-0.5}) \frac{\phi(x_i) - \phi(x_{i-1})}{x_i - x_{i-1}} \\
= -q N_{dop}^+(x_i)(x_{i+0.5} - x_{i-0.5})$$

## **Double-gate**

- 5-nm-thick Si substrate, 0.5-nm-thick oxide layers
  - -Si permittivity: 11.7
  - -SiO<sub>2</sub> permittivty: 3.9
  - P-type substrate: 10<sup>18</sup> cm<sup>-3</sup>

### Its solution

ullet Potential,  $\phi$ 



# Thank you!